

<b>Search Notes</b>  	<b>Application/Control No.</b>	<b>Applicant(s)/Patent Under Reexamination</b>
	10814548	HAILEY ET AL.
	<b>Examiner</b> Veillard, Jacques	<b>Art Unit</b> 2165

### SEARCHED

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
707	3 - 5, 8, 10, 100, 101, 102, 104.1, 103R, 203 (Updated)	3/14/2007	J.V
715	513, 530, 775 (Updated)	3/14/2007	J.V

### SEARCH NOTES

<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
Updated West Electronic Database search	3/14/2007	J.V
ACM Electronic Database Search	3/14/2007	J.V

### INTERFERENCE SEARCH

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
707	102, 103R	3/14/2007	J.V